MOSFETs Silicon P-/N-Channel MOS (U-MOSVI/U-MOSVI-H)

TPC8407

1. Applications

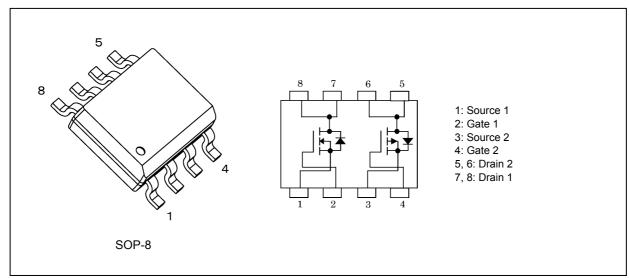
- Motor Drivers
- CCFL Inverters
- Mobile Equipments

2. Features

- (1) Small footprint due to a small and thin package
- (2) High speed switching

- (5) Enhancement mode P-channel $V_{th} = -0.8 \text{ to } -2.0 \text{ V} (V_{DS} = -10 \text{ V}, \text{ I}_{D} = -0.2 \text{ mA}),$ N-channel $V_{th} = 1.3 \text{ to } 2.3 \text{ V} (V_{DS} = 10 \text{ V}, \text{ I}_{D} = 0.1 \text{ mA})$

3. Packaging and Internal Circuit



4. Absolute Maximum Ratings (Note) ($T_a = 25^{\circ}C$ unless otherwise specified)

Characteristics	P/N	Symbol	Rating	Unit		
Drain-source voltage			P-ch	V _{DSS}	-30	V
			N-ch		30	
Gate-source voltage			P-ch	V _{GSS}	±20	
			N-ch		±20	
Drain current (DC)		(Note 1)	P-ch	I _D	-7.4	А
			N-ch		9	
Drain current (pulsed)	(Note 1)	P-ch	I _{DP}	-29.6	A	
			N-ch		36	
Power dissipation (single operation)	(t = 10 s)	(Note 2), (Note 4)	P-ch	P _{D(1)}	1.5	w
			N-ch		1.5	
Power dissipation (per device for dual	(t = 10 s)	(Note 2), (Note 5)	P-ch	P _{D(2)}	1.1	W
operation)		N-ch	N-ch		1.1	
Power dissipation (single operation)	(t = 10 s)	(Note 3), (Note 4)	P-ch	P _{D(1)}	0.75	W
			N-ch		0.75	
Power dissipation (per device for dual	(t = 10 s)	(Note 3), (Note 5)	P-ch	P _{D(2)}	0.45	W
operation)			N-ch		0.45	
Single-pulse avalanche energy		(Note 6)	P-ch	E _{AS}	35	mJ
			N-ch		52	
Avalanche current			P-ch	I _{AR}	-7.4	A
			N-ch		9	
Channel temperature			P-ch	T _{ch}	150	°C
			N-ch		150	
Storage temperature			P-ch	T _{stg}	-55 to 150	°C
			N-ch	1	-55 to 150	1

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

5. Thermal Characteristics

Characteristics	Symbol	Max	Unit		
Channel-to-ambient thermal resistance (single operation)	(t = 10 s)	(Note 2), (Note 4)	R _{th(ch-a)(1)}	83.3	°C/W
Channel-to-ambient thermal resistance (per device for dual operation)	(t = 10 s)	(Note 2), (Note 5)	R _{th(ch-a)(2)}	113	
Channel-to-ambient thermal resistance (single operation)	(t = 10 s)	(Note 3), (Note 4)	R _{th(ch-a)(1)}	166	
Channel-to-ambient thermal resistance (per device for dual operation)	(t = 10 s)	(Note 3), (Note 5)	R _{th(ch-a)(2)}	277	

Note 1: Ensure that the channel temperature does not exceed 150°C.

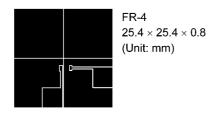
Note 2: Device mounted on a glass-epoxy board (a), Figure 5.1

Note 3: Device mounted on a glass-epoxy board (b), Figure 5.2

Note 4: Power dissipation and thermal resistance values per device with the other device being off (During single operation, power is supplied to only one of the two devices.)

Note 5: Power dissipation and thermal resistance values per device for dual operation (During dual operation, power is evenly supplied to both devices.)

Note 6: P channel: V_{DD} = -24 V, T_{ch} = 25°C (initial), L = 0.5 mH, R_G = 25 Ω , I_{AR} = -7.4 A N channel: V_{DD} = 24 V, T_{ch} = 25°C (initial), L = 0.5 mH, R_G = 25 Ω , I_{AR} = 9 A



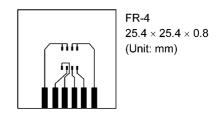
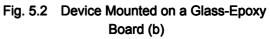


Fig. 5.1 Device Mounted on a Glass-Epoxy Board (a)



Note: This transistor is sensitive to electrostatic discharge and should be handled with care.

6. Electrical Characteristics

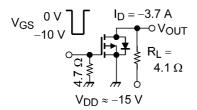
6.1. Static Characteristics ($T_a = 25^{\circ}C$ unless otherwise specified)

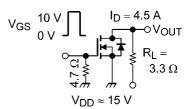
Characteristics	P/N	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current	P-ch	I _{GSS}	V_{GS} = ±20 V, V_{DS} = 0 V	_	_	±0.1	μA
	N-ch		V_{GS} = ±20 V, V_{DS} = 0 V	—		±0.1	
Drain cut-off current	P-ch	I _{DSS}	V_{DS} = -30 V, V_{GS} = 0 V	—		-10	μA
	N-ch	1	V _{DS} = 30 V, V _{GS} = 0 V	—	—	10	
Drain-source breakdown voltage	P-ch	V _{(BR)DSS}	I _D = -10 mA, V _{GS} = 0 V	-30		_	V
	N-ch		I _D = 10 mA, V _{GS} = 0 V	30		_	
Drain-source breakdown voltage (Note 7)	P-ch	V _{(BR)DSX}	$I_{\rm D}$ = -10 mA, $V_{\rm GS}$ = 10 V	-21		—	V
	N-ch		I_{D} = 10 mA, V_{GS} = -20 V	15		—	
Gate threshold voltage	P-ch	V _{th}	V_{DS} = -10 V, I _D = -0.2 mA	-0.8		-2.0	V
	N-ch		V _{DS} = 10 V, I _D = 0.1 mA	1.3		2.3	
Drain-source on-resistance	P-ch	R _{DS(ON)}	V_{GS} = -4.5 V, I _D = -3.7 A	—	23	29	mΩ
			V _{GS} = -10 V, I _D = -3.7 A	_	18	23	
	N-ch	1	V _{GS} = 4.5 V, I _D = 4.5 A	_	17	21	
			V _{GS} = 10 V, I _D = 4.5 A	_	14	17	

Note 7: If a reverse bias is applied between gate and source, this device enters V_{(BR)DSX} mode. Note that the drainsource breakdown voltage is lowered in this mode.

6.2. Dynamic Characteristics ($T_a = 25^{\circ}C$ unless otherwise specified)

Characteristics	P/N	Symbol	Test Condition	Min	Тур.	Max	Unit
Input capacitance	P-ch	C _{iss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	—	1650	_	pF
	N-ch		V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	-	1190	_	
Reverse transfer capacitance	P-ch	C _{rss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	260	_	pF
	N-ch		V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	55	_	
Output capacitance	P-ch	C _{oss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	300	_	pF
	N-ch		V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	210	_	
Switching time (rise time)	P-ch	t _r	See Figure 6.2.1.	—	8.0	_	ns
	N-ch		See Figure 6.2.2.	_	2.1	—	
Switching time (turn-on time)	P-ch	t _{on}	See Figure 6.2.1.	_	16	—	ns
	N-ch		See Figure 6.2.2.	—	7.9	_	
Switching time (fall time)	P-ch	t _f	See Figure 6.2.1.	—	42	—	ns
	N-ch		See Figure 6.2.2.	_	2.5	_	
Switching time (turn-off time)	P-ch	t _{off}	See Figure 6.2.1.	_	140	_	ns
	N-ch]	See Figure 6.2.2.	_	20	_	





Duty \leq 1%, t_W = 10 μs

Duty \leq 1%, $t_W =$ 10 μs

Fig. 6.2.1 Switching Time Test Circuit (P-ch) Fig. 6.2.2 Switching Time Test Circuit (N-ch)

6.3. Gate Charge Characteristics ($T_a = 25^{\circ}C$ unless otherwise specified)

Characteristics	P/N	Symbol	Test Condition	Min	Тур.	Max	Unit
Total gate charge (gate-source plus gate-drain)	P-ch	Qg	V _{DD} ≈ -24 V, V _{GS} = -10 V, I _D = -7.4 A	—	39	—	nC
	N-ch		$V_{DD} \approx 24 \text{ V}, V_{GS} = 10 \text{ V},$ $I_D = 9 \text{ A}$	—	17	—	
Gate-source charge 1	P-ch	Q _{gs1}	$V_{DD} \approx$ -24 V, V_{GS} = -10 V, I _D = -7.4 A	—	4.0	—	nC
	N-ch		$\label{eq:VDD} \begin{array}{l} V_{DD} \approx 24 \ V, \ V_{GS} \texttt{=} 10 \ V, \\ I_{D} \texttt{=} 9 \ A \end{array}$	—	3.7	—	
Gate-drain charge	P-ch	Q _{gd}	$V_{DD} \approx$ -24 V, V_{GS} = -10 V, I _D = -7.4 A	—	10	—	nC
	N-ch		$\label{eq:VDD} \begin{array}{l} V_{DD} \approx 24 \ V, \ V_{GS} \texttt{=} \ \texttt{10} \ V, \\ I_{D} \texttt{=} \ \texttt{9} \ A \end{array}$	—	1.8	—	

6.4. Source-Drain Characteristics ($T_a = 25^{\circ}C$ unless otherwise specified)

Characteristics		P/N	Symbol	Test Condition	Min	Тур.	Max	Unit
Reverse drain current	(Note 8)	P-ch	I _{DRP}	—	—	_	-29.6	А
(pulsed)		N-ch				—	36	
Diode forward voltage		P-ch	V _{DSF}	I _{DR} = -7.4 A, V _{GS} = 0 V		—	1.2	V
		N-ch		I _{DR} = 9 A, V _{GS} = 0 V		—	-1.2	

Note 8: Ensure that the channel temperature does not exceed 150°C.

7. Marking (Note)

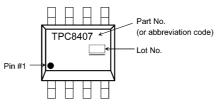


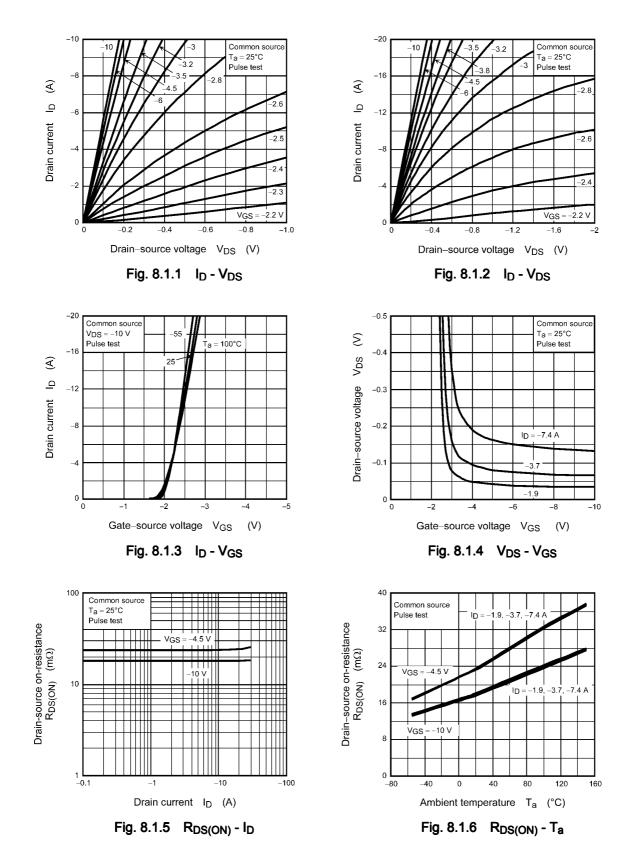
Fig. 7.1 Marking

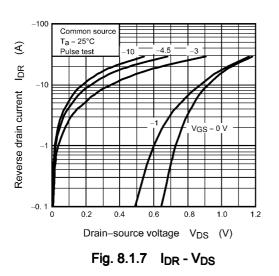
Note: A line under a Lot No. identifies the indication of product Labels. Not underlined: [[Pb]]/INCLUDES > MCV Underlined: [[G]]/RoHS COMPATIBLE or [[G]]/RoHS [[Pb]] Please contact your TOSHIBA sales representative for details as to environmental matters such as the RoHS compatibility of Product. The RoHS is the Directive 2002/05/EC of the European Parliament and of the Council of 27, January 2003 on

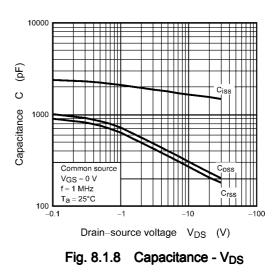
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8. Characteristics Curves (Note)

8.1. P-Channel MOSFET







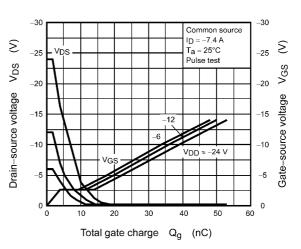
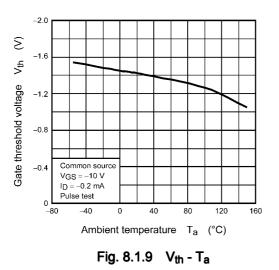
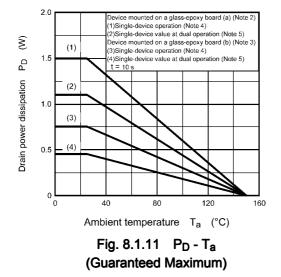


Fig. 8.1.10 Dynamic Input/Output Characteristics





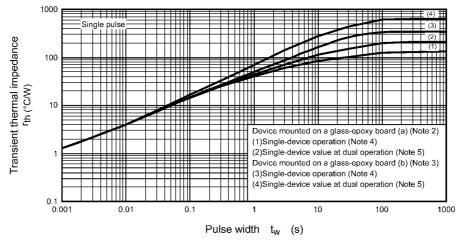
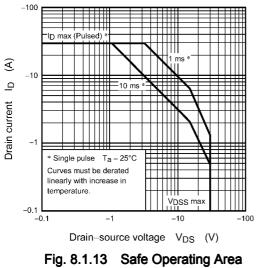


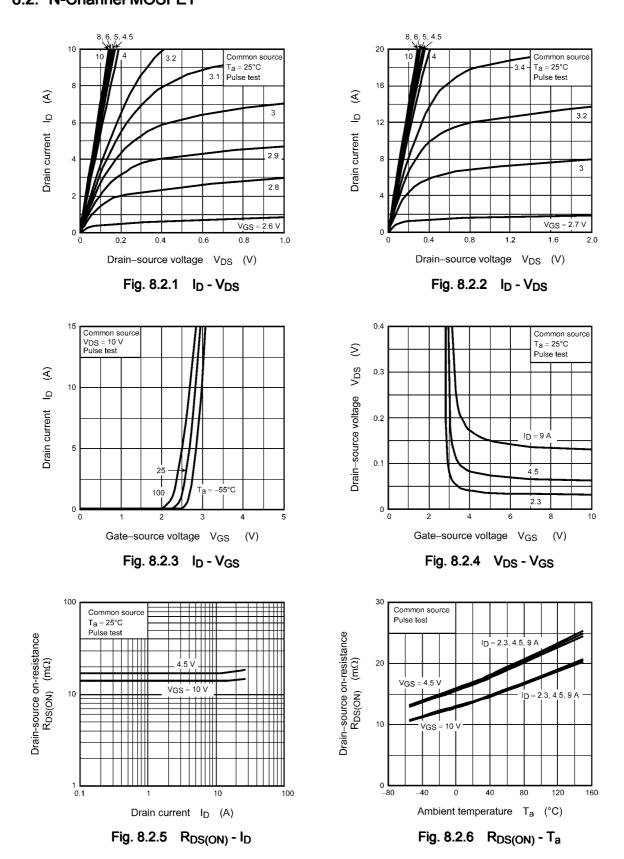
Fig. 8.1.12 r_{th} - t_w (Guaranteed Maximum)

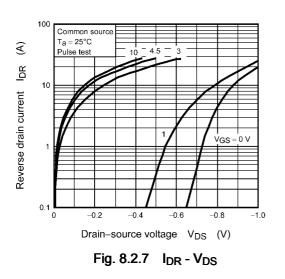


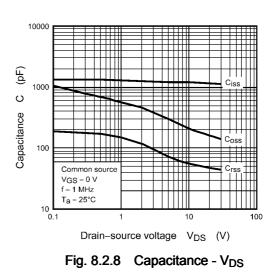
(Guaranteed Maximum)

8.2. N-Channel MOSFET

TOSHIBA







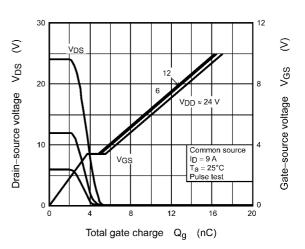
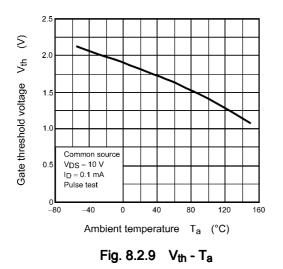
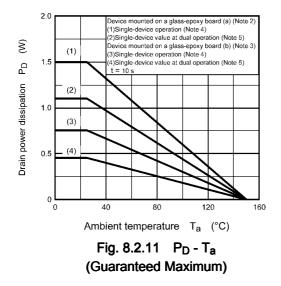
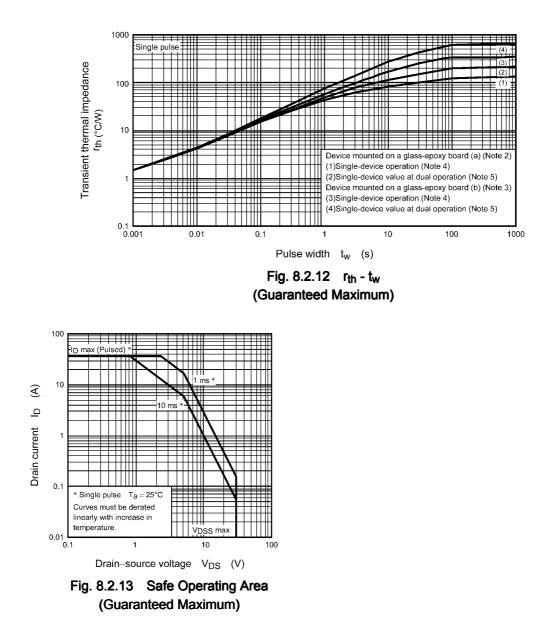


Fig. 8.2.10 Dynamic Input/Output Characteristics





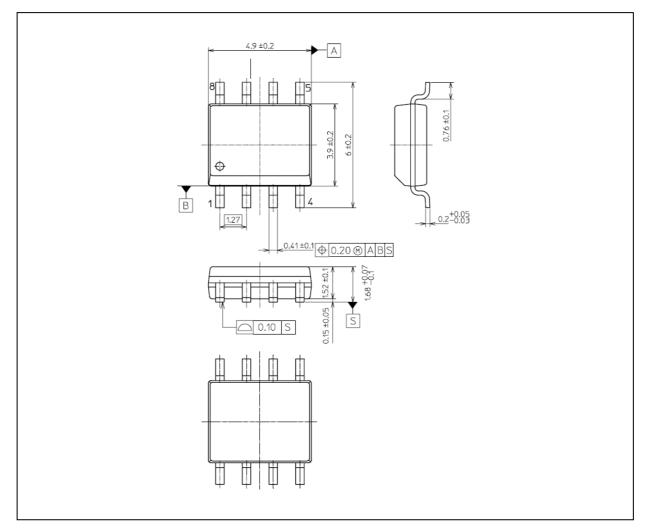


Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

Package Dimensions

Unit: mm

TPC8407



Weight: 0.085 g (typ.)

Package Name(s)	
TOSHIBA: 2-5R1S	
Nickname: SOP-8	

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